International Rectifier

IRF4905SPbF IRF4905LPbF

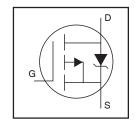
Features

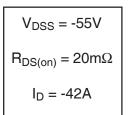
- Advanced Process Technology
- Ultra Low On-Resistance
- 150°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- Some Parameters Are Different from IRF4905S
- Lead-Free

Description

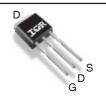
Features of this design are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of other applications.

HEXFET® Power MOSFET









D ² Pak
IRF4905SPbF

TO-262 IRF4905LPbF

G	D	S		
Gate	Drain	Source		

Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	-70	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	-44	Α
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	-42	
I _{DM}	Pulsed Drain Current ①	-280	
P _D @T _C = 25°C	Power Dissipation	170	W
	Linear Derating Factor	1.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy®	140	mJ
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	790	
I _{AR}	Avalanche Current ①	See Fig.12a, 12b, 15, 16	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T_{J}	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw ⑦	10 lbf•in (1.1N•m)	

Thermal Resistance

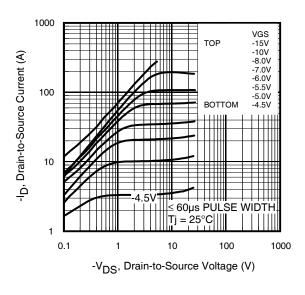
	Parameter	Typ.	Max.	Units	
$R_{\theta JC}$	Junction-to-Case ®		0.75		
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state) ②®		40		

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.054		V/°C	Reference to 25°C, I _D = -1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			20	mΩ	V _{GS} = -10V, I _D = -42A ③
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
gfs	Forward Transconductance	19			S	V _{DS} = -25V, I _D = -42A
I _{DSS}	Drain-to-Source Leakage Current			-25	μA	V _{DS} = -55V, V _{GS} = 0V
				-200		$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = -20V
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = 20V$
Q_g	Total Gate Charge		120	180		I _D = -42A
Q_{gs}	Gate-to-Source Charge		32		nC	$V_{DS} = -44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		53			V _{GS} = -10V ③
t _{d(on)}	Turn-On Delay Time		20			V _{DD} = -28V
t _r	Rise Time		99			I _D = -42A
$t_{d(off)}$	Turn-Off Delay Time		51		ns	$R_G = 2.6 \Omega$
t _f	Fall Time		64			V _{GS} = -10V ③
L _S	Internal Source Inductance		7.5		nΗ	Between lead,
						and center of die contact
C _{iss}	Input Capacitance		3500			$V_{GS} = 0V$
C _{oss}	Output Capacitance		1250			$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		450		pF	f = 1.0MHz
C _{oss}	Output Capacitance		4620			$V_{GS} = 0V, V_{DS} = -1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance		940			$V_{GS} = 0V$, $V_{DS} = -44V$, $f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		1530			$V_{GS} = 0V$, $V_{DS} = 0V$ to -44V \oplus

Source-Drain Ratings and Characteristics

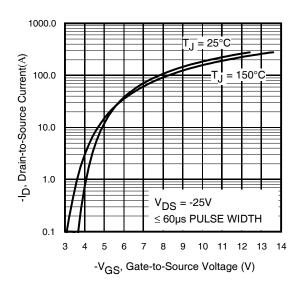
	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			-42		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			-280		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.3	٧	$T_J = 25^{\circ}C$, $I_S = -42A$, $V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		61	92	ns	$T_J = 25^{\circ}C, I_F = -42A, V_{DD} = -28V$
Q _{rr}	Reverse Recovery Charge		150	220	nC	di/dt = -100Α/μs ③
t _{on}	Forward Turn-On Time	Intrinsion	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			



 $(V) \ \ \, \text{tueuno} \ \ \, \text{top} \ \ \, \frac{15V}{-15V} \ \ \, \frac{-15V}{-10V} \ \ \, \frac{-8.0V}{-7.0V} \ \ \, \frac{-8.0V}{-7.0V} \ \ \, \frac{-8.0V}{-7.0V} \ \ \, \frac{-5.5V}{-5.5V} \ \ \, \frac{-5.5V}{-5.5V} \ \ \, \frac{-5.5V}{-4.5V} \ \ \, \frac{-4.5V}{-4.5V} \ \ \, \frac{-15V}{-4.5V} \$

Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



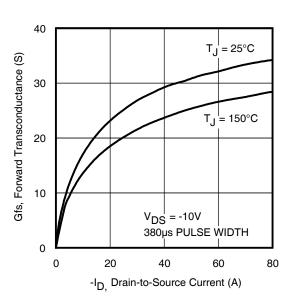


Fig 3. Typical Transfer Characteristics

Fig 4. Typical Forward Transconductance Vs. Drain Current

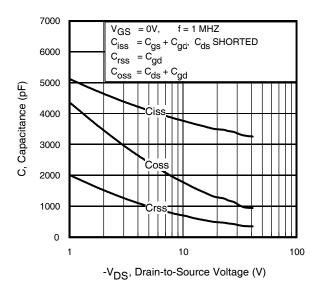


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

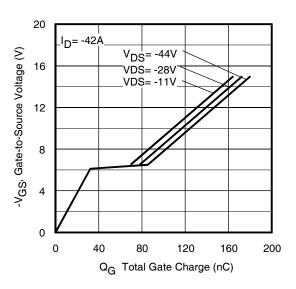


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

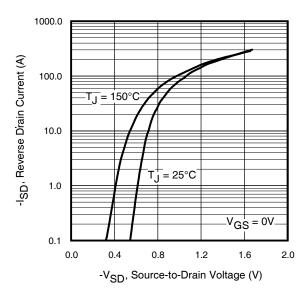


Fig 7. Typical Source-Drain Diode Forward Voltage

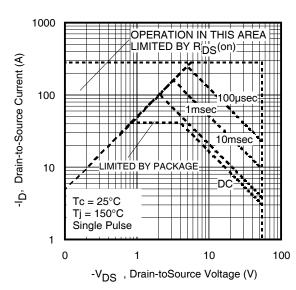


Fig 8. Maximum Safe Operating Area

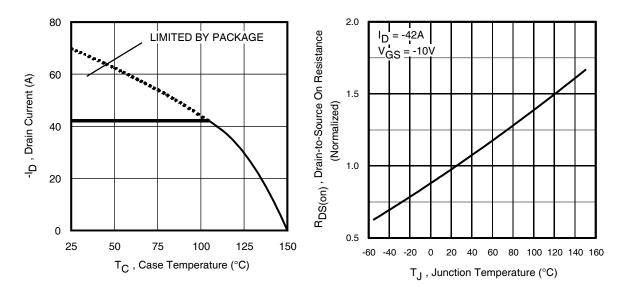


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

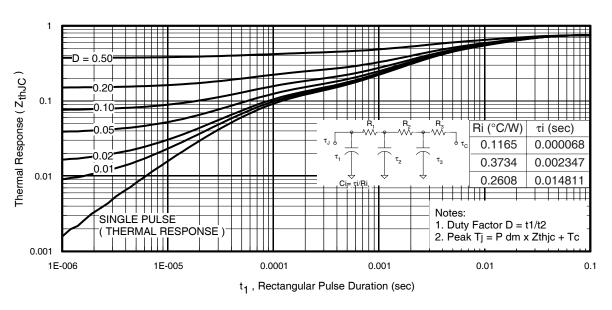


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

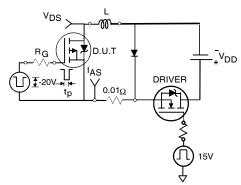


Fig 12a. Unclamped Inductive Test Circuit

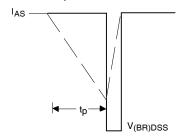


Fig 12b. Unclamped Inductive Waveforms

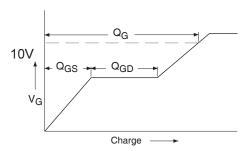


Fig 13a. Basic Gate Charge Waveform

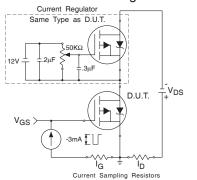


Fig 13b. Gate Charge Test Circuit 6

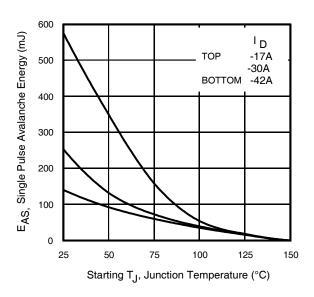


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

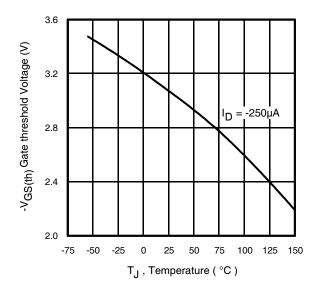


Fig 14. Threshold Voltage Vs. Temperature www.irf.com

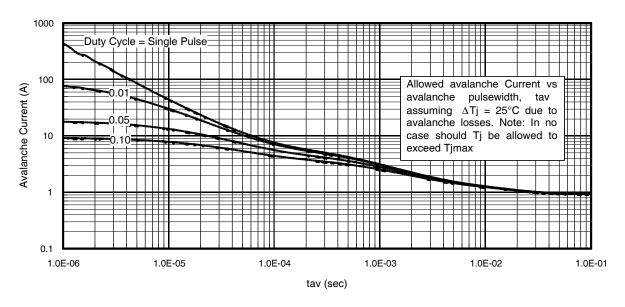


Fig 15. Typical Avalanche Current Vs. Pulsewidth

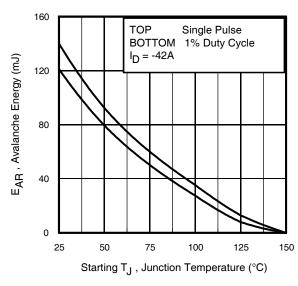


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 15, 16).

 t_{av} = Average time in avalanche.

 $D = Duty cycle in avalanche = t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3 \cdot BV \cdot I_{av}) = \triangle T/~Z_{thJC} \\ I_{av} &= 2\triangle T/~[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS~(AR)} &= P_{D~(ave)} \cdot t_{av} \end{split}$$

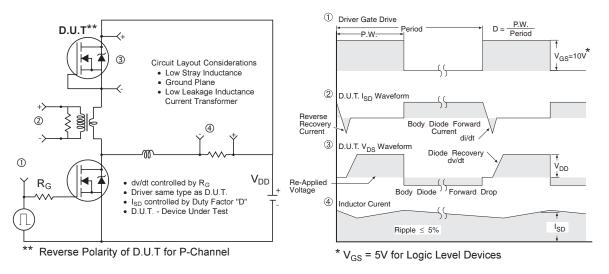


Fig 17. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power MOSFETs

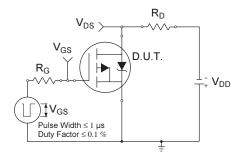


Fig 18a. Switching Time Test Circuit

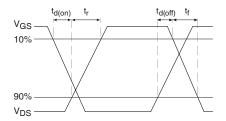
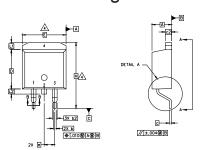
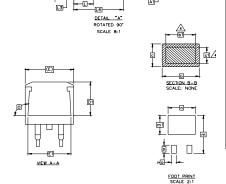


Fig 18b. Switching Time Waveforms

D²Pak Package Outline (Dimensions are shown in millimeters (inches))







NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE WOLD FLASH, WOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. DIMENSION 61 AND 61 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

S	DIMENSIONS							
M B O	MILLIM	ETERS	INC	INCHES				
L	MIN.	MAX.	MIN.	MAX.	E S			
Α	4.06	4.83	.160	.190				
A1	0.00	0.254	.000	.010				
ь	0.51	0.99	.020	.039				
ь1	0.51	0.89	.020	.035	4			
b2	1,14	1.78	.045	.070				
С	0.38	0.74	.015	.029				
c1	0.38	0.58	.015	.023	4			
c2	1,14	1.65	.045	.065				
D	8.51	9.65	.335	.380	3			
D1	6.86		.270					
E	9.65	10.67	.380	.420	3			
E1	6.22		.245					
e	2.54	BSC	.100	BSC				
Н	14.61	15.88	.575	.625				
L	1.78	2.79	.070	.110				
L1		1.65		.065				
L2	1.27	1.78	.050	.070				
L3	0.25	BSC	.010	BSC				
L4	4.78	5.28	.188	.208				
m	17.78		.700					
m1	8.89		.350					
n	11.43		.450					
0	2.08		.082					
р	3.81		.150					
R	0.51	0.71	.020	.028				
0	90,	93*	90*	93*				
				<u> </u>				

LEAD ASSIGNMENTS

HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

IGBTs, CoPACK

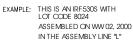
1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

DIODES

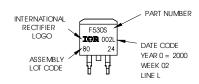
1.- ANODE *
2, 4.- CATHODE
3.- ANODE

* PART DEPENDENT.

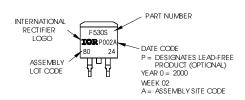
D²Pak Part Marking Information



Note: "P" in assembly line position indicates "Lead-Free"

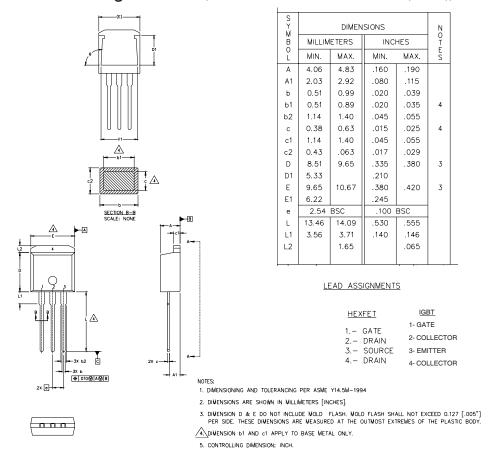




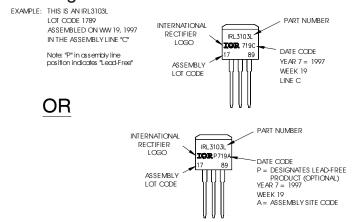


International TOR Rectifier

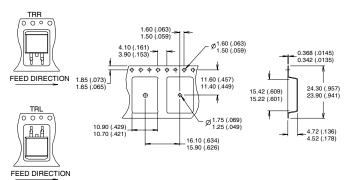
TO-262 Package Outline (Dimensions are shown in millimeters (inches))

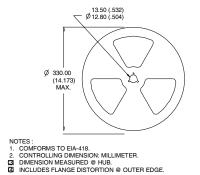


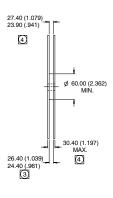
TO-262 Part Marking Information



D²Pak Tape & Reel Information







Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 0.16mH ⑥ R_G = 25 Ω , I_{AS} = -42A, V_{GS} =-10V. Part not recommended for use above this value. ②
- ③ Pulse width \leq 1.0ms; duty cycle \leq 2%.
- $\ \, \oplus \,\, C_{oss}$ eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- This value determined from sample failure population. 100% tested to this value in production.
- This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- R_θ is measured at T_J approximately 90°C

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market.

Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information. 08/05

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

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